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AON7520

30V N-Channel AlphaMOS

General Description

- Latest Trench Power AlphaMOS (αMOS LV) technology
- Very Low R_{DS(ON)} at 2.5V V_{GS}
- Low Gate Charge
- ESD protection
- RoHS and Halogen-Free Compliant

Product Summary

 $\begin{array}{lll} V_{DS} & 30V \\ I_D \; (at \; V_{GS} \! = \! 10V) & 50A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 1.8 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 2.1 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 2.5V) & < 3.1 m\Omega \end{array}$

Typical ESD protection

 $\begin{array}{cc} 100\% \text{ UIS Tested} \\ 100\% \text{ } \text{R}_{\text{g}} \text{ Tested} \end{array}$

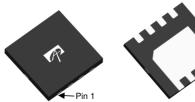
HBM Class 2

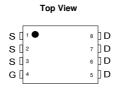


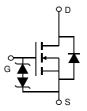
Application

· Load switch, battery switch in portable devices

Top View DFN 3.3x3.3 EP Bottom View







Absolute Maximum Ratings	T _A =25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage	е	V _{GS}	±12	V	
Continuous Drain	T _C =25℃		50		
Current ^G	T _C =100℃	I _D	39	A	
Pulsed Drain Current ^C		I _{DM}	200		
Continuous Drain	T _A =25℃		48	Λ	
Current	T _A =70℃	IDSM	38	A	
Avalanche Current C	,	I _{AS}	60	A	
Avalanche energy L	=0.05mH ^C	E _{AS}	90	mJ	
V _{DS} Spike	100ns	V _{SPIKE}	36	V	
	T _C =25°C P _D		83.3	W	
Power Dissipation ^B	T _C =100℃	T D	33.3	VV	
	T _A =25℃	В	6.2	W	
Power Dissipation ^A	T _A =70℃	P _{DSM}	4	VV	
Junction and Storag	e Temperature Range	T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	16	20	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	П _Ө ЈА	45	55	℃/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.1	1.5	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

$R_{DS(ON)} \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	0.85 1.45 2.05 1.66 2.35 125	1 5 ±10 1.2 1.8 2.6 2.1	V μΑ μΑ V
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$R_{DS(ON)} \begin{tabular}{lll} & & & & & & & & & & & & & & & & & &$	2.05 1.66 2.35	2.6	mΩ
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$\begin{array}{c ccccccccccccccccccccccccccccccccccc$,	i
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	125	3.1	
Is Maximum Body-Diode Continuous Current G DYNAMIC PARAMETERS C _{iss} Input Capacitance 4 C _{oss} Output Capacitance V _{GS} =0V, V _{DS} =15V, f=1MHz C _{rss} Reverse Transfer Capacitance 3 R _g Gate resistance V _{GS} =0V, V _{DS} =0V, f=1MHz SWITCHING PARAMETERS			S
$ \begin{array}{ c c c c c } \hline \textbf{DYNAMIC PARAMETERS} \\ \hline C_{iss} & Input Capacitance & & & 4 \\ \hline C_{oss} & Output Capacitance & V_{GS}=0V, V_{DS}=15V, f=1MHz & 19 \\ \hline C_{rss} & Reverse Transfer Capacitance & & & 3 \\ \hline R_g & Gate resistance & V_{GS}=0V, V_{DS}=0V, f=1MHz & 0.5 \\ \hline \textbf{SWITCHING PARAMETERS} \\ \hline \end{array} $	0.61	1	V
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		50	Α
$ \begin{array}{c cccc} C_{rss} & Reverse \ Transfer \ Capacitance & & & & 3 \\ R_g & Gate \ resistance & V_{GS}=0V, \ V_{DS}=0V, \ f=1MHz & 0.5 \\ \hline \textbf{SWITCHING PARAMETERS} & & & & \\ \end{array} $	4175		pF
R_{g} Gate resistance V_{GS} =0V, V_{DS} =0V, f=1MHz 0.5 SWITCHING PARAMETERS	1505		pF
SWITCHING PARAMETERS	300		pF
	1	1.5	Ω
Q _g (10V) Total Gate Charge 7			
	77.5	105	nC
$Q_g(4.5V)$ Total Gate Charge $V_{GS}=10V, V_{DS}=15V, I_D=20A$	37	50	nC
Q _{gs} Gate Source Charge	6		nC
Q _{gd} Gate Drain Charge 1	12.5		nC
t _{D(on)} Turn-On DelayTime	6.5		ns
t_r Turn-On Rise Time V_{GS} =10V, V_{DS} =15V, R_L =0.75 Ω ,	7		ns
$t_{D(off)}$ Turn-Off DelayTime $R_{GEN}=3\Omega$ 5	58.5		ns
t _f Turn-Off Fall Time 1	17.5		ns
t_{rr} Body Diode Reverse Recovery Time I_F =20A, dI/dt =500A/ μ s 2	20.3		ns
Q _{rr} Body Diode Reverse Recovery Charge I _F =20A, dI/dt=500A/μs 4			nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{8JA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

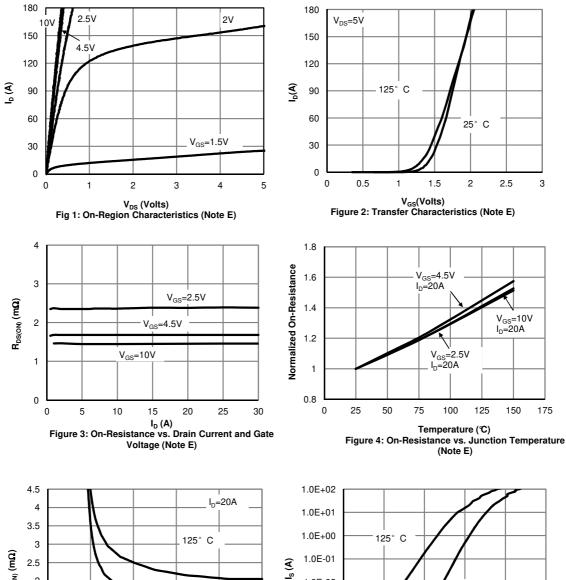
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

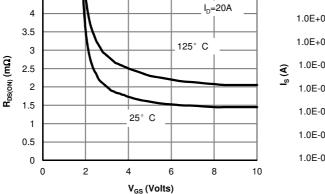
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C.

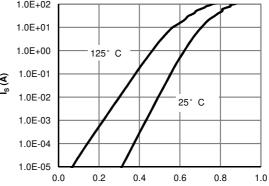


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

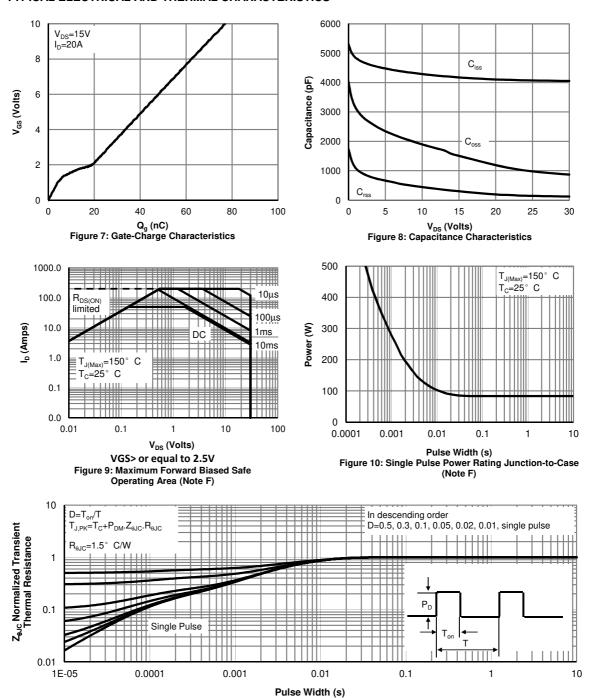
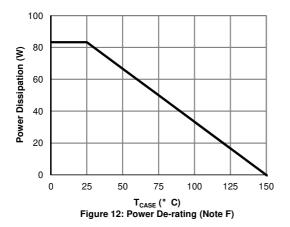
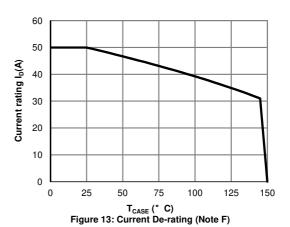


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





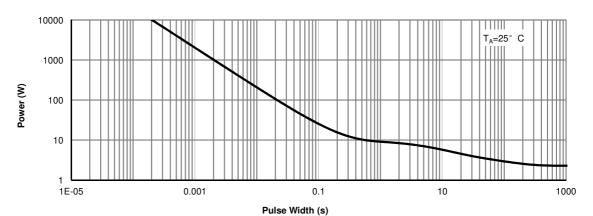
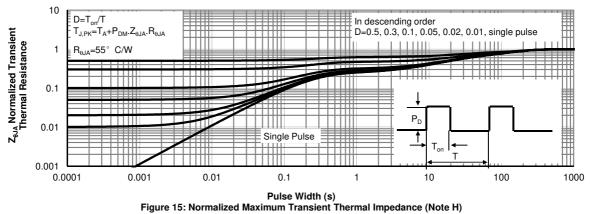
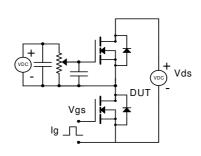


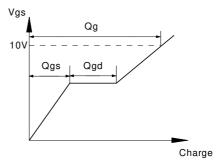
Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)



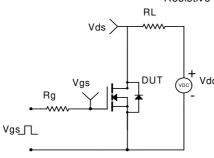


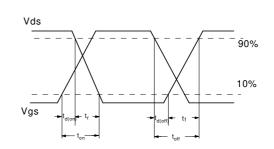
Gate Charge Test Circuit & Waveform



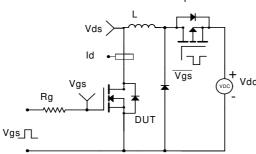


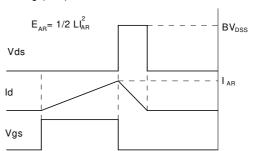
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

